

**Search Notes**

Application/Control No.

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Examiner

Jennifer Y. Cho

Applicant(s)/Patent under  
Reexamination

ITOH ET AL.

Art Unit

1621

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Search	6/21/2007	JC
Inventor Search	6/21/2007	JC
East Search	6/21/2007	JC